No.: RZC-K-HTS-0001 2017. 4. 21 Date:

Data sheet

Title: FIXED THICK FILM CHIP RESISTORS; RECTANGULAR

TYPE ANDULTRAHIGH VOLTAGE

Style: RZC50, 63

AEC-Q200 qualified

RoHS COMPLIANCE ITEM Halogen and Antimony Free

Note: • Stock conditions

Temperature: +5°C ~ +35°C Relative humidity: 25% ~ 75%

The period of guarantee: Within 2 year from shipmen t by the company.

Solderability shall be satisfied.

 Product specification contained in this data sheet are subject to change at any time without notice

If you have any questions or a Purchasing Specification for any quality

Agreement is necessary, please contact our sales staff.



Hokkaido Research Center Approval by: T. Sannomiya Drawing by: M. Shibuya

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FIXED THICK FILM CHIP RESISTORS; RECTANGULAR TYPE AND

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1. Scope

1.1 This data sheet covers the detail requirements for fixed thick film chip resistors; rectangular type and ultrahigh voltage, style of RZC50, 63.

1.2 Applicable documents

JIS C 5201-1: 2011, JIS C 5201-8: 2014, JIS C 5201-8-1: 2014 IEC60115-1: 2008, IEC60115-8: 2009, IEC60115-8-1: 2014 EIAJ RC-2134C-2010

2. Classification

Type designation shall be the following form.

(Example)

RZC	63	_	475	J	TE
1	2	3	4	5	6
Sty	le				

- 1 Fixed thick film chip resistors; rectangular type & ultrahigh voltage Style
- 2 Rated dissipation and / or dimension
- 3 Temperature coefficient of resistance
- 4 Rated resistance Example; $475 \rightarrow 4.7M\Omega$

475 E24 Series, 3 digit, Ex. 475	> 4.7MΩ,
----------------------------------	----------

5 Tolerance on rated resistance

J	±5%
K	±10%
М	±20%

6 Packaging form

9119 101111	
В	Bulk (loose package)
TE	Embossed taping

3. Rating

3.1 The ratings shall be in accordance with Table-1.

Table-1

Style	Rated dissipation (W)	Temperature or resistance (Rated resistance range (Ω)	Preferred number Series for resistors	Tolerance on rated resistance
RZC50	0.5	Standard	±200	1M~16M	E24	(/_E0/)
RZC63	1.0	Statituatu	±200	TIVI~ TOIVI	EZ4	J(±5%), K(±10%), M(±20%)

		1	
Ct. da	Limiting element voltage	Isolation voltage	Category temperature range
Style	(V)	(V)	(°C)
RZC50	1500	500	FF .40F
RZC63	2000	500	<i>–</i> 55∼+125

3.2 Climatic category

55/125/56 Lower category temperature -55°C Upper category temperature +125 °C Duration of the damp heat, steady state test 56days Title: FIXED THICK FILM CHIP RESISTORS; RECTANGULAR TYPE AND

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3.3 Stability class

5% Limits for change of resistance:

-for long–term tests \pm (5%+0.1Ω) -for short–term tests \pm (1%+0.05Ω)

3.4 Derating

The derated values of dissipation at temperature in excess of 70 °C shall be as indicated by the following curve.

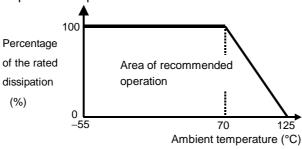


Figure-1 Derating curve

3.5 Rated voltage

d. c. or a. c. r. m. s. voltage calculated from the square root of the product of the rated resistance and the rated dissipation.

$$E = \sqrt{P \cdot R}$$

E: Rated voltage (V)

P: Rated dissipation (W)

R : Rated resistance (Ω)

Limiting element voltage can only be applied to resistors when the resistance value is equal to or higher than the critical resistance value.

At high value of resistance, the rated voltage may not be applicable.

4. Packaging form

The standard packaging form shall be in accordance with Table-2.

Table-2

Symbol	Packaging form		Standard packaging quantity / units
В	Bulk (loose package)		1,000 pcs.
TE	Embossed taping	12mm width, 4mm pitches	4,000 pcs.

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5. Dimensions

5.1 The resistor shall be of the design and physical dimensions in accordance with Figure-2 and Table-3.

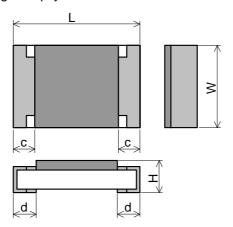


Figure-2

		Table	- 3	Uı	nit : mm
Style	L	W	Н	С	d
RZC50	5.0 ± 0.15	2.5 ± 0.15	0.55 ± 0.15	0.6 ± 0.2	0.6 ± 0.2
RZC63	6.3 ± 0.15	3.2 ± 0.15	0.55 ± 0.15	0.6 ± 0.2	0.6 ± 0.2

5.2 Net weight (Reference)

Style	Net weight(mg)
RZC50	25
RZC63	40

6. Marking

The Rated resistance shall be marked in 3 digits (E24) and marked on over coat side. (Example) "475" \rightarrow 47 ×10 $^{5}[\Omega] \rightarrow$ 4.7 [M Ω]

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7. Performance

7.1 The standard condition for tests shall be in accordance with Sub-clause 4.2, JIS C 5201-1: 2011

7.2 The performance shall be satisfied in Table-4.

Table 4(1)

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		1able-4(1)	
No.	Test items	Condition of test (JIS C 5201–1)	Performance requirements
1	Visual examination	Sub-clause 4.4.1	As in 4.4.1
		Checked by visual examination.	The marking shall be legible, as
			checked by visual examination.
2	Dimension	Sub-clause 4.4.2	As specified in Table-3 of this
	5		specification.
	Resistance	Sub-clause 4.5	As in 4.5.2
			The resistance value shall correspond
			with the rated resistance taking into account the specified tolerance.
3	Voltage proof	Sub-clause 4.7	No breakdown or flash over
3	voltage proof	Method: 4.6.1.4(See Figure–5)	INO DIEARGOWITOI IIASITOVEI
		Test voltage: Alternating voltage with a peak	
		value of 1.42 times the insulation voltage.	
		Duration: 60 s ± 5 s	
		Insulation resistance	R≥1GΩ
		Test voltage: Insulation voltage	
		Duration: 1 min.	
4	Solderability	Sub-clause 4.17	As in 4.17.4.5
		Without ageing	The terminations shall be covered with
		Flux: The resistors shall be immersed in a	a smooth and bright solder coating.
		non-activated soldering flux for 2s.	
		Bath temperature: 235 °C ± 5 °C	
		Immersion time: 2 s ± 0.5 s	
5	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
	Overload	Test substrate: Figure–3 Sub–clause 4.13	
	(in the mounted state)	The applied voltage shall be 2.5 times the	
	(iii a io i iio a iio a o acco)	rated voltage or twice the limiting element	
		voltage which ever is less severe.	
		Duration: 2 s	
		Visual examination	
		Resistance	No visible damage
			$\Delta R \le \pm (1\% + 0.05\Omega)$
		Sub-clause 4.30	
	Solvent resistance of the	Solvent: 2-propanol	Legible marking
	marking	Solvent temperature: 23 °C ± 5 °C	
		Method 1	
		Rubbing material: cotton wool	
		Without recovery	

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Table-4(2)

No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
6	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–4	
	Bound strength of the end	Sub-clause 4.33	
	face plating	Bent value: 1 mm	
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$
	Final measurements	Sub-clause 4.33.6	
		Visual examination	No visible damage
7	Resistance to soldering heat	Sub-clause 4.18	
		Solvent temperature: 260 °C ± 5 °C	
		Immersion time: 5 s ± 0.5 s	
		Visual examination	As in 4.18.3.4
			No sign of damage such as cracks.
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$
	Component solvent	Sub-clause 4.29	
	resistance	Solvent: 2-propanol	
		Solvent temperature: 23 °C ± 5 °C	
		Method 2	
		Recovery: 48 h	
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$
8	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Adhesion	Sub-clause 4.32	
		Force: 5 N	
		Duration: 10 s ± 1 s	
	Basistatia and tananant an	Visual examination	No visible damage
	Rapid change temperature	Sub-clause 4.19	
		Lower category temperature:	
		_55 °C	
		Upper category temperature: +125 °C	
		Duration of exposure at each temperature: 30	
		min.	
		Number of cycles: 5 cycles.	
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$

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Table-4(3)

		1abi c 4 (3)	
No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
9	Climatic sequence	Sub-clause 4.23	
	-Dry heat	Sub-clause 4.23.2	
	-	Test temperature: +125 °C	
		Duration: 16 h	
	-Damp heat, cycle	Sub-clause 4.23.3	
	(12+12hour cycle)	Test method: 2	
	First cycle	Test temperature: 55 °C	
	•	[Severity(2)]	
	-Cold	Sub-clause 4.23.4	
		Test temperature –55 °C	
		Duration: 2h	
	-Damp heat, cycle	Sub-clause 4.23.6	
	(12+12hour cycle)	Test method: 2	
	Remaining cycle	Test temperature: 55 °C	
		[Severity (2)]	
		Number of cycles: 5 cycles	
	–D.C. load	Sub-clause 4.23.7	
		The applied voltage shall be the rated voltage	
		or the limiting element voltage which ever is	
		the smaller.	
		Duration: 1 min.	Nie Sellie de como
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (5\% + 0.1\Omega)$
10	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		(RZC63 may use Alumina substrate.)	
		Test substrate: Figure–3	
	Endurance at 70 °C	Sub-clause 4.25.1	
		Ambient temperature: 70 °C ± 2 °C	
		Duration: 1000 h	
		The voltage shall be applied in cycles of 1.5 h	
		on and 0.5 h.	
		The applied voltage shall be the rated voltage	
		or the limiting element voltage which ever is	
		the smaller.	
		Examination at 48 h , 500 h and	
		1000 h:	NI - 2-20 In de conse
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (5\% + 0.1\Omega)$
11	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Variation of resistance with	Sub-clause 4.8	As in Table–1
	temperature	–55 °C / +20 °C	
		+20 °C / +125°C	

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Table-4(4)

No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
12	Mounting	Sub-clause 4.31	·
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Damp heat, steady state	Sub-clause 4.24	
		Ambient temperature: 40 °C ± 2 °C	
		Relative humidity: 93^{+2}_{-3} %	
		a) 1st group: without voltage applied.	
		b) 2nd group: The d. c. voltage shall be	
		applied continuously.	
		The voltage shall be accordance with	
		Sub-clause 4.24.2.1 b). without polarizing	
		voltage [4.24.2.1, c)]	No visible damage
		Visual examination	Legible marking
			$\Delta R \le \pm (5\% + 0.1\Omega)$
		Resistance	,
13	Dimensions (detail)	Sub-clause 4.4.3	As in Table–3
	Mounting	0 1 1 1 1 1 1 1 1 1	
	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
	Endurance at upper category	Test substrate: Figure–3 Sub–clause 4.25.3	
	temperature	Ambient temperature:125 °C ± 2 °C	
		Duration: 1000 h	
		Examination at 48 h, 500 h and	
		1000 h:	
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (5\% + 0.1\Omega)$
14	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure-3	
	Anti-rush voltage test	Ambient temperature:25°C ± 2°C	
		The voltage shall be applied in cycles of 1 s	
		"ON", 9 s "OFF".	
		Test voltage: 3000V	No visible demage
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$

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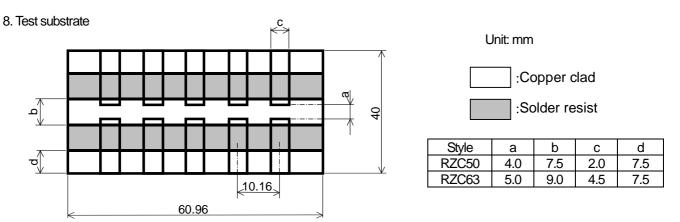


Figure-3 RZC50, 63 TEST SUBSTRATE

Remark 1). Material: Epoxide woven glass

Thickness: 1.6mm Thickness of copper clad: 0.035mm

2). In the case of connection by connector, the connecting terminals are gold plated. However, the plating is not necessary when the connection is made by soldering.

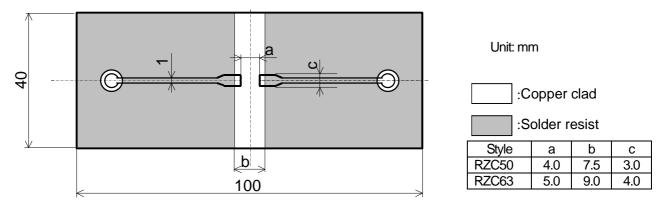


Figure-4 RZC50, 63 BOUND STRENGTH OF THE END FACE PLATING TEST SUBSTRATE

Remark 1). Material: Epoxide woven glass

Thickness: 1.6mm Thickness of copper clad: 0.035mm

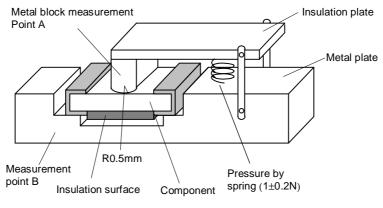


Figure-5

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9. Taping

- 9.1 Applicable documents JIS C 0806–3: 2014, EIAJ ET–7200C: 2010
- 9.2 Taping dimensions

Embossed taping dimensions shall be in accordance with Figure-6 and Table-5.

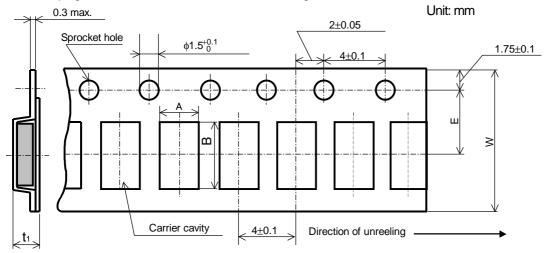


Figure-6
Table-5
Unit: mm

B W E t

5.5±0.2
6.9±0.2

12.0±0.3

5.5±0.05

1.1±0.15

- 1). The cover tapes shall not cover the sprocket holes.
- Tapes in adjacent layers shall not stick together in the packing.

Style

RZC50

RZC63

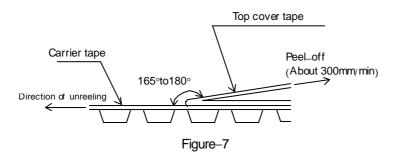
- 3). Components shall not stick to the carrier tape or to the cover tape.
- 4). Pitch tolerance over any 10 pitches ±0.2mm.
- 5). The peel strength of the top cover tape shall be with in 0.1N to 0.5N on the test method as shown in the following Figure–7.
- 6). When the tape is bent with the minimum radius for 30 mm, the tape shall not be damaged and the components shall maintain their position and orientation in the tape.
- 7). In no case shall there be two or more consecutive components missing.

 The maximum number of missing components shall be one or 0.1%, whichever is greater.
- 8). The resistors shall be faced to upward at the over coating side in the carrier cavity.

Α

 3.1 ± 0.2

 3.6 ± 0.2



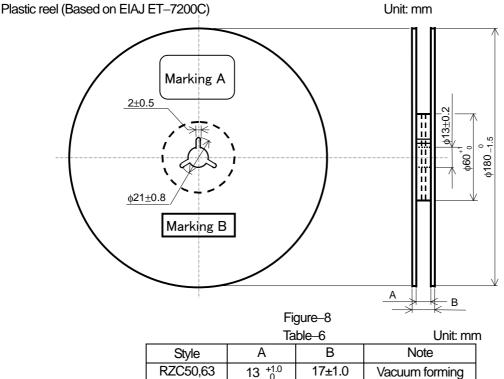
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9.3 Reel dimension

Reel dimensions shall be in accordance with the following Figure-8 and Table-6.



Note: Marking label shall be marked on a place of Marking A or two place of marking A and B.

9.4 Leader and trailer tape.

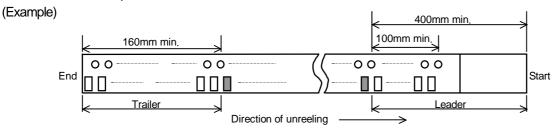


Figure-9

10. Marking on package

The label of a minimum package shall be legibly marked with follows.

10.1 Marking A

- (1) Classification (Style, Rated resistance, Tolerance on rated resistance, Packaging form)
- (2) Quantity (3) Lot number (4) Manufacturer's name or trade mark (5) Others
- 10.2 Marking B (KAMAYA Control label)

单击下面可查看定价,库存,交付和生命周期等信息

>>Kamaya(釜屋电机)